NX5P2090

Logic controlled high-side power switch Rev. 2.1 — 15 January 2015

Product data sheet

General description 1.

The NX5P2090 is an advanced power switch for USB OTG applications. It includes under-voltage and over-voltage lockout, over-current, over-temperature, reverse bias and in-rush current protection circuits. These are designed to automatically isolate a VBUS OTG voltage source from a VBUS interface pin when a fault occurs. The device features two power switch terminals, one input (VINT) and one output (VBUS); a current limit input (ILIM) for defining the over-current and in-rush current limit; a voltage detect output (VDET) to monitor the voltage level on VBUS; an open-drain fault output (FAULT) to indicate when a fault condition has occurred and an enable input (EN) to control the state of the switch. When EN is set LOW the device enters a low-power mode, disabling all protection circuits except the under-voltage lockout. The low-power mode can be entered at anytime unless the over temperature protection circuit has been triggered.

Designed for operation from 3 V to 5.5 V, it is used in power domain isolation applications to protect from out of range operation. The enable input includes integrated logic level translation making the device compatible with lower voltage processors and controllers.

Features and benefits 2.

- Wide supply voltage range from 3 V to 5.5 V
- 30 V tolerant on VBUS
- I_{SW} maximum 2 A continuous current
- Very low ON resistance: 100 mΩ (maximum) at a supply voltage of 4.0 V
- Low-power mode (ground current 20 μA typical)
- 1.8 V control logic
- Soft start turn-on slew rate
- Protection circuitry
 - Over-temperature protection
 - Over-current protection with low current output mode
 - Reverse bias current/Back drive protection
 - Over-voltage lockout
 - Under-voltage lockout
 - Analog voltage limited VBUS monitor path
- ESD protection:
 - HBM ANSI/ESDA/JEDEC JS-001 Class 2 exceeds 2 kV
 - IEC61000-4-2 contact discharge exceeds 8 kV for pins VBUS
- Specified from –40 °C to +85 °C



3. Applications

USB OTG applications

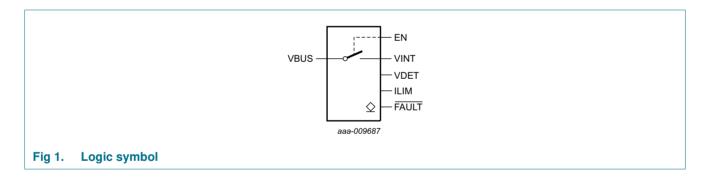
4. Ordering information

| Table 1. Ordering information | | | | | | | | | |
|---------------------------------------|-------------------|--------|--|------------|--|--|--|--|--|
| Type number Package | | | | | | | | | |
| | Temperature range | Name | Description | Version | | | | | |
| NX5P2090UK | –40 °C to +85 °C | WLCSP9 | wafer level chip-scale package; 9 bumps; body 1.36 x 1.36 x 0.51 mm. (Backside Coating included) | NX5P2090UK | | | | | |

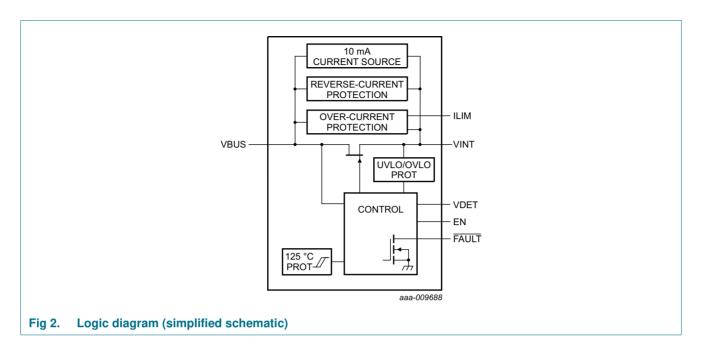
5. Marking

| Table 2. Marking codes | |
|--------------------------|--------------|
| Type number | Marking code |
| NX5P2090UK | NX5P2 |

6. Functional diagram

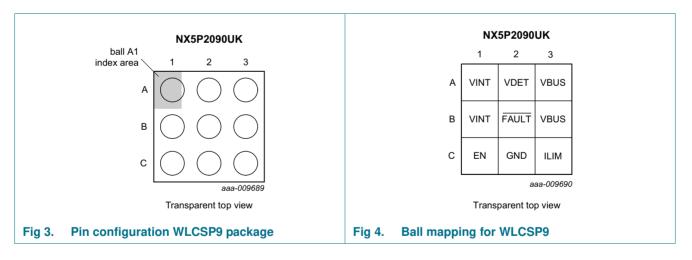


NX5P2090



7. Pinning information

7.1 Pinning



7.2 Pin description

| Table 3. | Pin description | | |
|----------|-----------------|--------|--|
| Symbol | | Pin | Description |
| VINT | | A1, B1 | internal circuitry voltage I |
| VBUS | | A3, B3 | external connector voltage O |
| EN | | C1 | enable input (active HIGH) I |
| ILIM | | C3 | current limiter I/O |
| VDET | | A2 | VBUS voltage level indicator O |
| FAULT | | B2 | fault condition indicator (open-drain; active LOW) |
| GND | | C2 | ground (0 V) |

8. Functional description

| Table | 4. Function ta | able ^[1] | | |
|-------|----------------|---|-------|--|
| EN | VINT | VBUS | FAULT | Operation mode |
| Х | 0 V | Z | L | No supply |
| Х | 0 V | < 30 V | Z | Disabled; switch open |
| Х | < 3.2 V | Z | L | Under-voltage lockout; switch open |
| Н | > 5.5 V | Z | L | Over-voltage lockout; switch open |
| Н | 3.2 V to 5.5 V | Z | L | Over-temperature; switch open |
| L | 3.2 V to 5.5 V | Z | Z | Disabled; switch open |
| Н | 3.2 V to 5.5 V | VBUS = VINT | Z | Enabled; switch closed; active |
| Н | 3.2 V to 5.5 V | 0 V to VINT | L | Over-current; Switch open; constant current on VBUS |
| Η | 3.2 V to 5.5 V | 0 V to VINT | L | When ILIM is connected to GND, VBUS is default supplied with 10 mA current source |
| Н | 3.2 V to 5.5 V | VINT + 30 mV < VBUS < VINT + 0.45 V (> 4 ms) | L | Reverse bias current/back drive; switch open |
| Н | 3.2 V to 5.5 V | VBUS > VINT + 0.7 V | L | Reverse bias current/back drive; switch open |

[1] H = HIGH voltage level; L = LOW voltage level, Z = high-impedance OFF-state, X = Don't care.

Table 5. Function table VDET versus VBUS^[1]

| VBUS | VDET | Operation mode |
|-------------------|--------------------|---------------------------|
| 3 V < VBUS < 30 V | 1.5 < VDET < 5.5 V | VDET detects VBUS voltage |

[1] See Figure 22.

8.1 EN input

If EN is set LOW, the N-channel MOSFET is disabled, the FAULT output is set HIGH-impedance and the device enters low-power mode. In low-power mode, all protection circuits are disabled except the under-voltage lockout circuit. If EN is set HIGH, all protection circuits are reactivated. If no fault conditions exist and an R_{ILIM} current limit resistor is detected, the N-channel MOSFET is enabled.

8.2 Under-voltage lockout (UVLO)

The UVLO circuit is active until VINT > 3.2 V. It disables the N-channel MOSFET, sets the FAULT output LOW and returns the device to low-power mode. This occurs independently of the logic level on the EN pin. Once VINT > 3.2 V, the EN pin controls the N-channel MOSFET state. The UVLO circuit remains active in low-power mode.

8.3 Over-voltage lockout (OVLO)

If EN is set HIGH and VINT > 5.75 V, the OVLO circuit is active. It disables the N-channel MOSFET and sets the FAULT output LOW. In low-power mode, the OVLO circuit is disabled and does not change the FAULT output state. If the OVLO circuit is active, setting the EN pin LOW returns the device to low-power mode.

8.4 ILIM

The over-current protection circuit's (OCP) trigger value I_{ocp} , is set using an external resistor connected to the ILIM pin (see <u>Figure 6</u>). If EN is set HIGH and the ILIM pin is grounded, the device is in over-current. The N-channel MOSFET is disabled, the FAULT output is set LOW and VBUS supplied by the 10 mA current source.

8.5 Over-current protection (OCP)

When the current through the N-channel MOSFET exceeds I_{ocp} for 20 μ s or VBUS < VINT – 200 mV, the device is in over-current. The OCP circuit disables the N-channel MOSFET within 2 μ s, sets the FAULT output LOW and supplies VBUS from the 10 mA current source. The OCP circuit is automatically reset when VINT > VBUS > VINT – 200 mV for 20 μ s. The N-channel MOSFET assumes the state defined by EN, the 10 mA current source is disconnected and the FAULT output is set HIGH-impedance. If the OCP circuit is active, setting the EN pin LOW returns the device to low-power mode.

8.6 Over-temperature protection (OTP)

If EN is set HIGH and the device temperature exceeds 125 °C, the device is in over temperature. The OTP circuit disables the N-channel MOSFET and sets the FAULT output LOW. Transitions on the EN pin have no effect. Once its temperature decreases to below 115 °C the device returns to the defined state. The OTP circuit is disabled in low-power mode.

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8.7 Reverse bias current/back drive protection (RCP)

The reverse bias current protection circuit can only be triggered when EN is set HIGH. If VBUS > (VINT + 30 mV) for longer than 4 ms; or VBUS > (VINT + 0.45 V) the device is in reverse bias. The RCP circuit disables the N-channel MOSFET and sets the FAULT output LOW. Once VBUS < VINT for longer than 4 ms the device returns to the defined state. If the RCP circuit is active, setting the EN pin LOW returns the device to low-power mode.

8.8 **FAULT** output

The FAULT output is an open-drain output that requires an external pull-up resistor. If any of the UVLO, OVLO, RCP, OCP or OTP circuits is activated, the FAULT output is set LOW to indicate that a fault has occurred. The FAULT output returns to the high impedance state automatically once the fault condition is removed.

8.9 VDET output

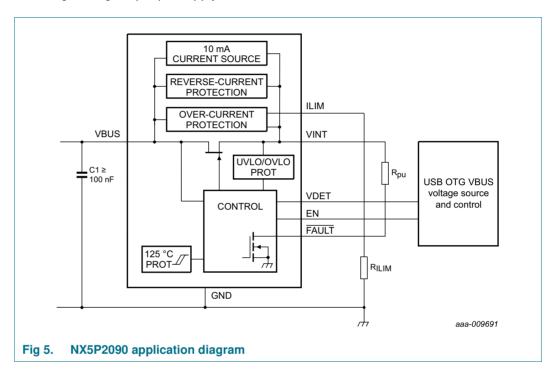
VDET is an analog output that allows a controller to monitor the voltage level on VBUS.

8.10 In-rush current protection

When the N-channel MOSFET is enabled, the in-rush current protection circuit clamps the switch current until VBUS = VINT -200 mV. The resistor connected to ILIM sets the clamp current. The in-rush current protection circuit is disabled in low-power mode.

9. Application diagram

The NX5P2090 typically connects a voltage source on VINT to the VBUS of a USB connector supporting USB3 OTG in a portable, battery operated device. The external resistor R_{ILIM} sets the maximum current limit threshold. The FAULT signal requires an additional external pull-up resistor which should be connected to a supply voltage matching the logic input pin supply level it is connected to.



10. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| | | , | 0 | | 10 | / |
|---------------------|---------------------------------|-----------------------------|---|---------------|------------|------|
| Symbol | Parameter | Conditions | | Min | Мах | Unit |
| VI | input voltage | VBUS | | 1 -0.5 | +32 | V |
| | | VINT | | <u>1</u> –0.5 | +6.0 | V |
| | | EN, ILIM | | 2 –0.5 | VINT + 0.5 | V |
| Vo | output voltage | FAULT | | -0.5 | +6.0 | V |
| I _{IK} | input clamping current | EN: V _I < -0.5 V | | -50 | - | mA |
| I _{SK} | switch clamping current | VBUS; VINT; $V_I < -0.5 V$ | | -50 | - | mA |
| I _{SW} | switch current | T _{amb} = 85 °C | | - | ±2000 | mA |
| T _{j(max)} | maximum junction temperature | | | -40 | +125 | °C |
| T _{stg} | storage temperature | | | -65 | +150 | °C |

Table 6. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|-------------------------|------------|--------------|-----|------|
| P _{tot} | total power dissipation | | <u>[3]</u> - | 400 | mW |

[1] The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed.

[2] The minimum input voltage rating may be exceeded if the input current rating is observed.

[3] The (absolute) maximum power dissipation depends on the junction temperature T_j . Higher power dissipation is allowed in conjunction with lower ambient temperatures. The conditions to determine the specified values are $T_{amb} = 85$ °C and the use of a two layer PCB.

11. Recommended operating conditions

Decommonded encycting conditions

| Table 7. | Recommended operating c | onations | | | |
|------------------|-------------------------|----------------|-----|------|------|
| Symbol | Parameter | Conditions | Min | Max | Unit |
| VI | input voltage | VINT | 3.0 | 5.5 | V |
| | | EN, ILIM | 0 | VINT | V |
| Vo | output voltage | VBUS; EN = LOW | 0 | 30 | V |
| T _{amb} | ambient temperature | | -40 | +85 | °C |

12. Thermal characteristics

Table 8. Thermal characteristics

Table 7

| Symbol | Parameter | Conditions | Тур | Unit |
|----------------------|---|------------|--------|------|
| R _{th(j-a)} | thermal resistance from junction to ambient | | [1] 82 | K/W |

[1] The overall Rth(j-a) can vary depending on the board layout. To minimize the effective Rth(j-a), all pins must have a solid connection to larger Cu layer areas e.g. to the power and ground layer. In multi-layer PCB applications, the second layer should be used to create a large heat spreader area right below the device. If this layer is either ground or power, it should be connected with several vias to the top layer connecting to the device ground or supply. Avoid using solder-stop varnish under the device.

13. Static characteristics

Table 9. Static characteristics

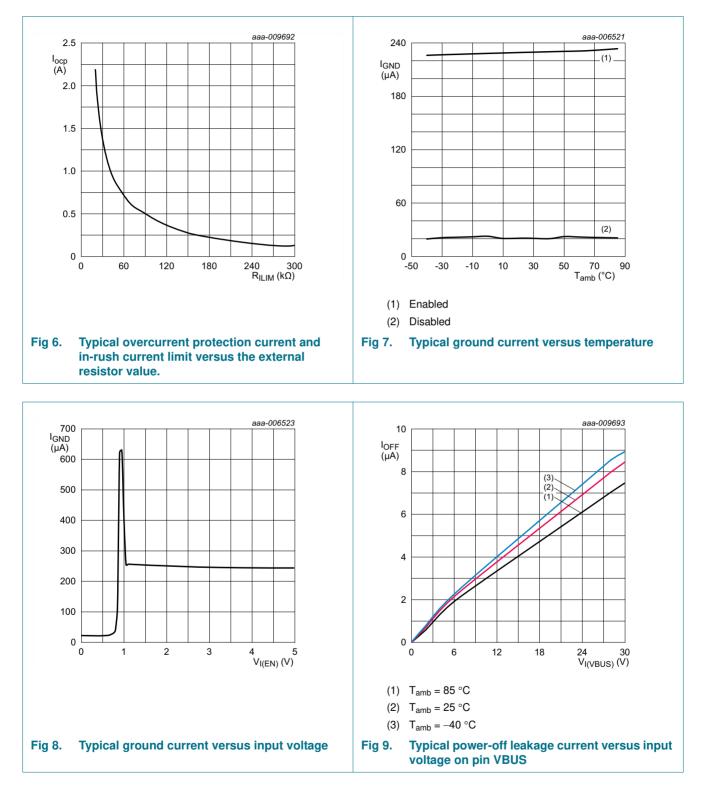
 $V_{I(V|NT)} = 4.0 \text{ V}$ to 5.5 V; unless otherwise specified; Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | | Ta | _{mb} = 25 | °C | $T_{amb} = -40$ ° | C to +85 °C | Unit |
|------------------------|---|--|-----|-----|----------------------|------------------|-------------------|------------------|------|
| | | | | Min | Typ <mark>[1]</mark> | Max | Min | Мах | |
| V _{IH} | HIGH-level input voltage | EN input | | 1.2 | - | - | 1.2 | - | V |
| V _{IL} | LOW-level input voltage | EN input | | - | - | 0.4 | - | 0.4 | V |
| Vo | output voltage | VDET; I _{VDET} = -2 mA; 3 V < VBUS < 30 V | | 1.5 | - | 5.5 | 1.5 | 5.5 | V |
| V _{OL} | LOW-level output voltage | FAULT, I _O = 8 mA | | - | - | 0.5 | - | 0.5 | V |
| lo | output current | Current source | | - | 10 | - | 8 | 15 | mA |
| | | $EN = HIGH; \overline{FAULT} = Hi-Z$ | | - | - | I _{ocp} | - | I _{ocp} | mA |
| I _{ocp} | overcurrent protection current | EN = HIGH; see <u>Figure 6</u> | | - | - | - | - | - | mA |
| R _{pu} | pull-up resistance | FAULT | | 20 | - | 200 | - | - | kΩ |
| V _{pu} | pull-up voltage | FAULT | | - | - | VINT | - | VINT | V |
| R _{ILIM} | current limit resistance | ILIM | | 20 | - | 300 | 20 | 300 | kΩ |
| I _{GND} | ground current | VBUS open; EN = LOW; see <u>Figure 7</u> and <u>Figure 8</u> | | - | 20 | - | - | 40 | μA |
| | | VBUS open; EN = HIGH; see <u>Figure 7</u> and <u>Figure 8</u> | | - | 220 | - | - | 360 | μA |
| I _{OFF} | power-off leakage current | VBUS = 0 V to 30 V; VINT = 0 V; see <u>Figure 9</u> | [2] | - | 2 | - | - | 20 | μA |
| I _{S(OFF)} | OFF-state leakage current | VBUS = 0 V to 30 V; see <u>Figure 10</u> and <u>Figure 11</u> | [2] | - | 2 | - | - | 20 | μA |
| V _{UVLO} | undervoltage lockout voltage | | | 3.0 | 3.2 | 3.4 | 3.0 | 3.4 | V |
| V _{OVLO} | overvoltage lockout voltage | | | 5.5 | 5.9 | 6.25 | 5.5 | 6.25 | V |
| V _{hys(OVLO)} | overvoltage lockout hysteresis voltage | | | - | 150 | - | - | - | mV |
| Cı | input capacitance | EN | | - | 2 | - | - | - | pF |
| C _{S(ON)} | ON-state capacitance | | | - | - | 1 | - | 1 | nF |

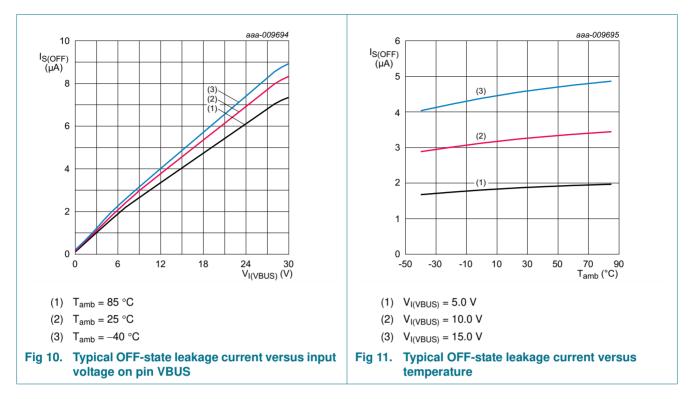
[1] Typical values are measured at $T_{amb} = 25 \text{ °C}$ and $V_{I(VINT)} = 5.0 \text{ V}$.

[2] Typical value is measured at T_{amb} = 25 °C and $V_{I(VBUS)}$ = 5.0 V.

13.1 Graphs



NX5P2090



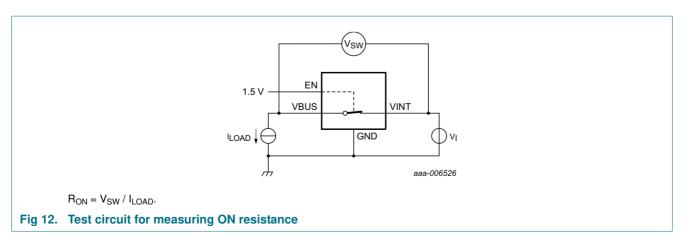
13.2 ON resistance

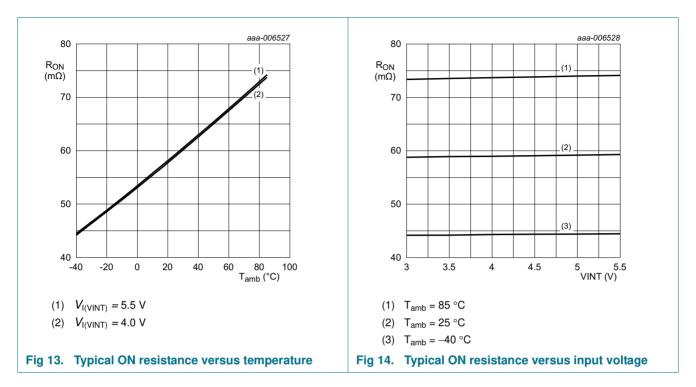
Table 10.ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V)

| Symbol | Parameter | Conditions | Tar | T _{amb} = 25 °C | | T _{amb} = -40 °C to +85 °C | | Unit |
|-----------------|---------------|--|-----|--------------------------|-----|-------------------------------------|-----|------|
| | | | Min | Тур | Мах | Min | Max | |
| R _{ON} | ON resistance | switch enabled; $I_{LOAD} = 200 \text{ mA}$; see <u>Figure 12</u> , <u>Figure 13</u> and <u>Figure 14</u> | | | | | | |
| | | $V_{I(VINT)} = 4.0 \text{ V}$ to 5.5 V | - | 60 | - | - | 100 | mΩ |

13.3 ON resistance test circuit and waveforms





14. Dynamic characteristics

Table 11. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit, see <u>Figure 16</u>. $V_{I(VINT)} = 4.0 V$ to 5.5 V.

| Symbol | Parameter | Conditions | Ta | _{mb} = 25 | °C | T _{amb} = -40 ° | °C to +85 °C | Unit |
|------------------|--|---------------------------|-----|--------------------|-----|--------------------------|--------------|------|
| | | | Min | Тур | Max | Min | Max | |
| t _{en} | enable time | EN to VBUS; see Figure 15 | - | 0.24 | - | 0.16 | - | ms |
| t _{dis} | disable time | EN to VBUS; see Figure 15 | - | 1.5 | - | - | - | ms |
| t _{on} | turn-on time | EN to VBUS; see Figure 15 | - | 0.63 | - | 0.52 | - | ms |
| t _{off} | turn-off time | EN to VBUS; see Figure 15 | - | 34.5 | - | - | - | ms |
| t _{TLH} | LOW to HIGH output transition time | VBUS; see Figure 15 | - | 0.39 | - | 0.16 | - | ms |
| t _{THL} | HIGH to LOW output transition time | VBUS; see Figure 15 | - | 33 | - | - | - | ms |

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14.1 Waveform and test circuits

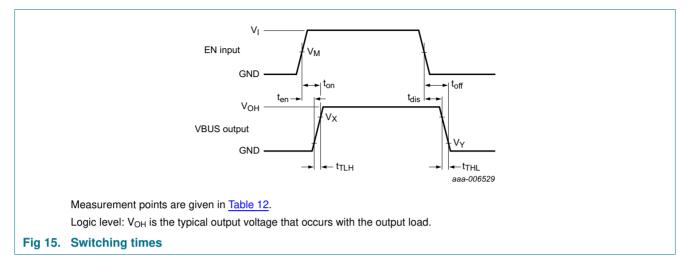


Table 12. Measurement points

| Supply voltage | EN Input | Output | |
|----------------------|-----------------|--------------------|---------------------|
| V _{I(VINT)} | V _M | V _X | V _Y |
| 4.0 V to 5.5 V | $0.5 	imes V_I$ | $0.9 	imes V_{OH}$ | $0.1 \times V_{OH}$ |

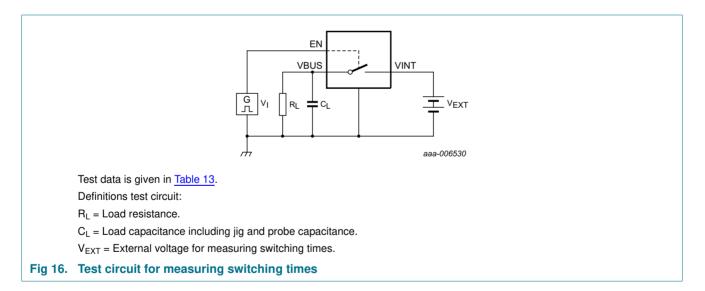
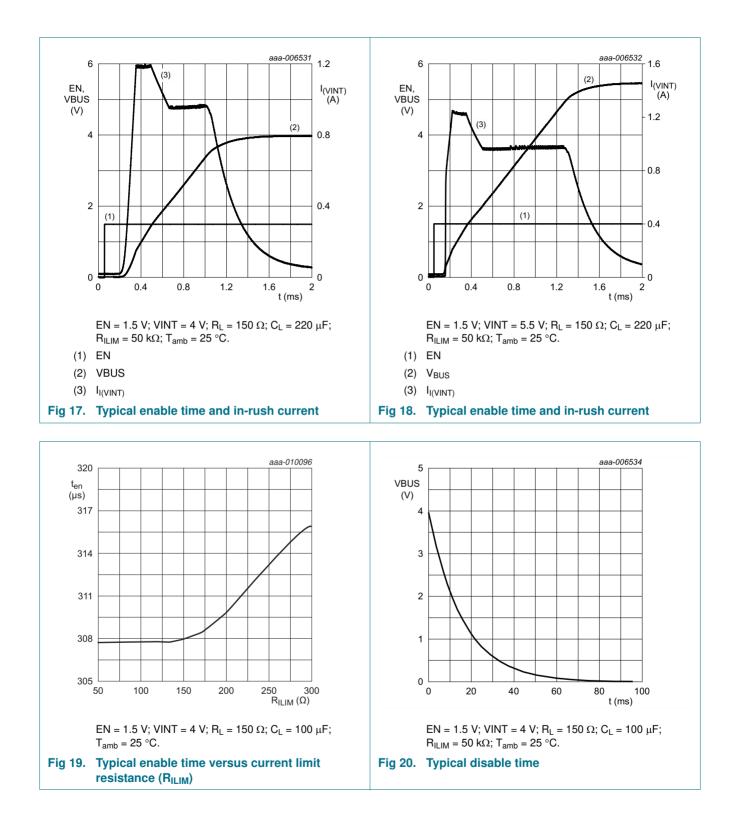


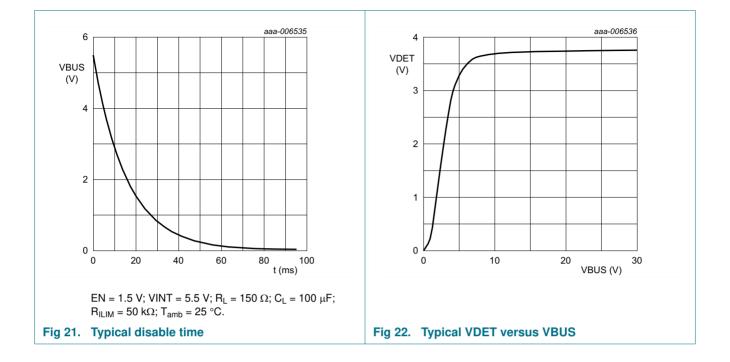
Table 13. Test data

| Supply voltage | Input | Load | |
|------------------|-------|--------|-------|
| V _{EXT} | VI | CL | RL |
| 4.0 V to 5.5 V | 1.5 V | 100 μF | 150 Ω |



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Logic controlled high-side power switch



15. Package outline

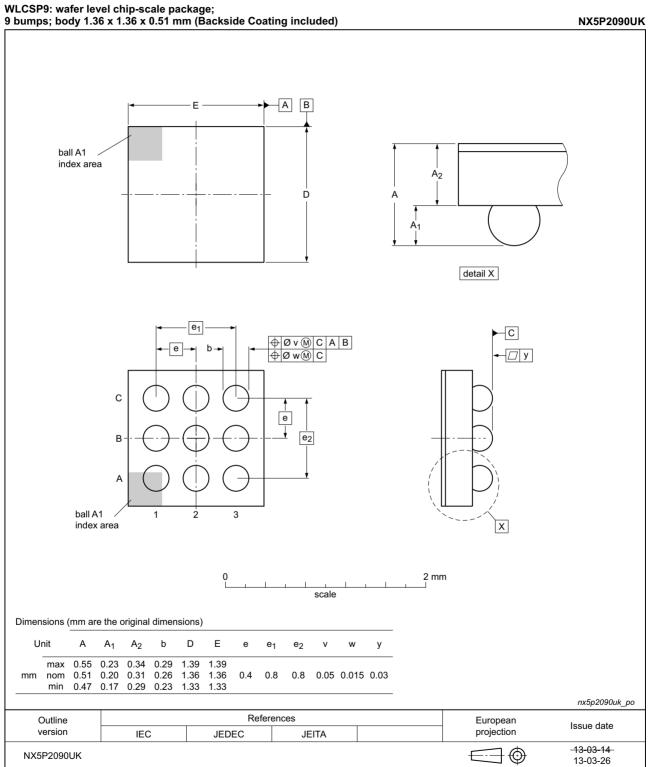


Fig 23. Package outline WLCSP9 package

16. Abbreviations

| Table 14. Abbrev | iations |
|------------------|---|
| Acronym | Description |
| CDM | Charged Device Model |
| DUT | Device Under Test |
| ESD | ElectroStatic Discharge |
| HBM | Human Body Model |
| MOSFET | Metal-Oxide Semiconductor Field Effect Transistor |
| OCP | OverCurrent Protection |
| OTP | OverTemperature Protection |
| RCP | Reverse Current Protection |
| USB OTG | Universal Serial Bus On-The-Go |
| UVLO | Under-voltage lockout |
| VBUS | USB Power Supply |
| OVLO | Over-voltage lockout |

17. Revision history

Table 15.Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------|---------------------------------|---------------------------------|---------------|--------------|
| NX5P2090 v.2.1 | 20150115 | Product data sheet | - | NX5P2090 v.2 |
| Modifications: | A text correct | ction to the first paragraph or | n page 1. | |
| NX5P2090 v.2 | 20131212 | Product data sheet | - | NX5P2090 v.1 |
| Modifications: | Status chan | ged to Product data sheet. | | |
| NX5P2090 v.1 | 20130812 | Preliminary data sheet | - | - |

18. Legal information

18.1 Data sheet status

| Document status[1][2] | Product status ^[3] | Definition |
|--------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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Logic controlled high-side power switch

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